

Application/Control No. 10/801,940	Applicant(s)/Patent under Reexamination BAEK ET AL.
Examiner	Art Unit
Brian M. Healy	2883

				ISSUE	CI	AS	SIF	ICAT	ION						
		ORIGINAL			INTERNATIONAL CLASSIFICATION										
	ASS			С	LAIMED										
	1	G	92	В	6	/10			1						
	CROSS REFERENCES							21	/00			,			
CLASS	SUBCLA	ASS (ONE SU	JBCLASS PE	R BLOCK)	Н	0 1	_	21	700						
385	14	129	130			1			1			1			
438	29 31								1			1			
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						M. H Y EX	EAL		Total Claims Allowed: 12						
ART UNI										O.G. Print Fig.					
(Legal Instruments Examiner) (Date) (Prim						ner)		(Date)		11					

⊠c	Claims renumbered in the same order as presented by applicant								□ СРА			☐ T.D.			☐ R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			151			181
2	2			32			62			92			122			152			182
3	3			33			63			93			123			153			183
4	4			34			64			94			124			154			184
5	5			35			65			95			125			155			185
6	6			_36			66			96			126			156			186
7	7]		37			67]		97			127			157			187
8	8			38			68			98			128			158			188
9	9			39			69			99			129			159			189
10	10			40			70			100			130			160			190
11	11]		41			71			101			131			161			191
12	12			42			72			102			132			162			192
	13			43			73			103			133			163			193
	14			44			74	1		104			134			164			194
	15			45			75]		105			135			165			195
	16			46			76	Ì		106			136			166			196
	17			47			77	}		107			137			167			197
	18			48			78	Ì		108			138			168			198
	19			49			79]		109			139			169			199
	20			50			80			110	:		140			170			200
	21			51			81	Ì		111			141			171			201
	22			52			82	1		112			142			172			202
	23			53			83			113			143			173			203
	24			54			84			114			144			174			204
	25			55			85			115			145			175	i		205
	26			56			86			116			146			176			206
	27			57			87			117			147			177			207
	28			58	!		88			118			148			178			208
	29			59			89			119			149			179			209
	30			60			90			120			150			180			210